

<b>Notice of References Cited</b>	Application/Control No. 10/665,219	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,722,950 B1	04-2004	Dabral et al.	451/36
*	B	US-6,797,623 B2	09-2004	Sato et al.	438/691
*	C	US-6,846,227 B2	01-2005	Sato et al.	451/288
*	D	US-2002/0108861 A1	08-2002	Emesh et al.	205/81
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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